



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Shunpei Yamazaki et al.      Art Unit : 2811  
Serial No. : 10/693,491      Examiner : Unknown  
Filed : October 27, 2003  
Title : SEMICONDUCTOR DEVICE AND FABRICATION METHOD THEREOF

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449.

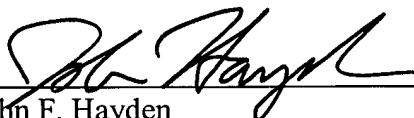
This statement is being filed before the receipt of a first Office action on the merits.

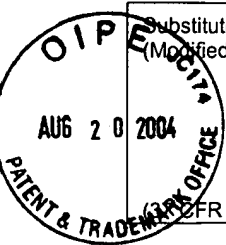
Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: August 20, 2004

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-097002	Application No. 10/693,491
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date October 27, 2003	Group Art Unit 2811

### U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,852,481	12/22/1998	HWANG			
	AB	6,180,439	01/30/2001	YAMAZAKI et al.			
	AC	6,197,624	03/06/2001	YAMAZAKI			
	AD	6,529,251	03/04/2003	HIBINO et al.			
	AE	6,599,785	07/29/2003	HAMADA et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

### Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	AL	JP06-148685	27 MAY 1994	JAPAN			FULL	
	AM	JP07-235680	05 SEP 1995	JAPAN			FULL	
	AN	JP2000-241832	08 SEP 2000	JAPAN			ABSTRACT	
	AO							

### Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AP	
	AQ	
	AR	
	AS	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	